

AOD4184/AOI4184

40V N-Channel MOSFET

General Description

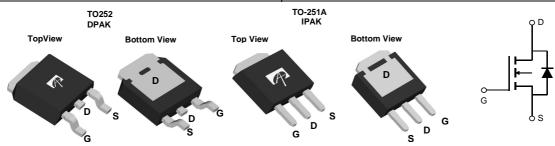
The AOD4184/AOI4184 used advanced trench technology and design to provide excellent $R_{\rm DS(ON)}$ with low gate charge. With the excellent thermal resistance of the DPAK package, those devices are well suited for high current load applications.

Product Summary

 $\begin{array}{ll} V_{DS} & 40V \\ I_D \; (at \; V_{GS} \! = \! 10V) & 50A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 8m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 4.5V) & < 11m\Omega \end{array}$

 $\begin{array}{cc} 100\% \; UIS \; Tested \\ 100\% \; \; R_g \; Tested \end{array}$





Absolute Maximum Ratings T_A=25℃ unless otherwise noted

| Parameter | | Symbol | Maximum | Units | |
|----------------------------------------|----------------------|-----------------------------------|------------|-------|--|
| Drain-Source Voltage | | V _{DS} | 40 | V | |
| Gate-Source Voltage | | V _{GS} | ±20 | V | |
| Continuous Drain | T _C =25℃ | | 50 | | |
| Current ^G | T _C =100℃ | 'D | 40 | A | |
| Pulsed Drain Current ^C | | I _{DM} | 120 | | |
| Continuous Drain | T _A =25℃ | | 12 | Δ. | |
| Current | T _A =70℃ | IDSM | 9.5 | A | |
| Avalanche Current ^C | | I _{AS} , I _{AR} | 35 | A | |
| Avalanche energy L=0.1mH ^C | | E _{AS} , E _{AR} | 61 | mJ | |
| | T _C =25℃ | P _D | 50 | W | |
| Power Dissipation ^B | T _C =100℃ | ' D | 25 | VV | |
| | T _A =25℃ | Р | 2.3 | W | |
| Power Dissipation A | T _A =70℃ | P _{DSM} | 1.5 | VV | |
| Junction and Storage Temperature Range | | T _J , T _{STG} | -55 to 175 | C. | |

| Thermal Characteristics | | | | | | | | |
|---------------------------------|--------------|-----------------|-----|-------|-----|--|--|--|
| Parameter | Symbol | Тур | Max | Units | | | | |
| Maximum Junction-to-Ambient A | t ≤ 10s | | 18 | 22 | C/W | | | |
| Maximum Junction-to-Ambient AD | Steady-State | $R_{\theta JA}$ | 44 | 55 | ℃/W | | | |
| Maximum Junction-to-Case Steady | | $R_{\theta JC}$ | 2.4 | 3 | ℃/W | | | |



Electrical Characteristics (T_J=25℃ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Тур | Max | Units | | | | |
|-----------------------|------------------------------------|---------------------------------------------------|------|------|------|-------|--|--|--|--|
| STATIC PARAMETERS | | | | | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ | 40 | | | V | | | | |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =40V, V _{GS} =0V | | | 1 | μА | | | | |
| | | T _J =55℃ | | | 5 | | | | | |
| I_{GSS} | Gate-Body leakage current | V_{DS} =0V, V_{GS} =±20V | | | ±100 | nA | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS} I_{D}=250\mu A$ | 1.7 | 2.2 | 2.6 | V | | | | |
| I _{D(ON)} | On state drain current | V_{GS} =10V, V_{DS} =5V | 120 | | | Α | | | | |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} =10V, I _D =20A | | 6.7 | 8 | mΩ | | | | |
| | | T _J =125℃ | | 11 | 13 | 11122 | | | | |
| | | V _{GS} =4.5V, I _D =15A | | 8.5 | 11 | mΩ | | | | |
| g _{FS} | Forward Transconductance | $V_{DS}=5V$, $I_D=20A$ | | 37 | | S | | | | |
| V_{SD} | Diode Forward Voltage | I _S =1A,V _{GS} =0V | | 0.72 | 1 | V | | | | |
| Is | Maximum Body-Diode Continuous Curr | | | 20 | Α | | | | | |
| DYNAMIC | PARAMETERS | | | | | | | | | |
| C _{iss} | Input Capacitance | | 1200 | 1500 | 1800 | pF | | | | |
| C _{oss} | Output Capacitance | V_{GS} =0V, V_{DS} =20V, f=1MHz | 150 | 215 | 280 | pF | | | | |
| C _{rss} | Reverse Transfer Capacitance | | 80 | 135 | 190 | pF | | | | |
| R_g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | 2 | 3.5 | 5 | Ω | | | | |
| SWITCHI | NG PARAMETERS | | | | | | | | | |
| Q _g (10V) | Total Gate Charge | | 21 | 27.2 | 33 | nC | | | | |
| Q _g (4.5V) | Total Gate Charge | V -10V V -20V I -20A | 10 | 13.6 | 16 | nC | | | | |
| Q_{gs} | Gate Source Charge | V_{GS} =10V, V_{DS} =20V, I_{D} =20A | | 4.5 | | nC | | | | |
| Q_{gd} | Gate Drain Charge | 1 | | 6.4 | | nC | | | | |
| t _{D(on)} | Turn-On DelayTime | | | 6.4 | | ns | | | | |
| t _r | Turn-On Rise Time | V_{GS} =10V, V_{DS} =20V, R_L =1 Ω , | | 17.2 | | ns | | | | |
| t _{D(off)} | Turn-Off DelayTime | $R_{GEN}=3\Omega$ | | 29.6 | | ns | | | | |
| t _f | Turn-Off Fall Time |] | | 16.8 | | ns | | | | |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =20A, dI/dt=100A/μs | 20 | 29 | 38 | ns | | | | |
| Q_{rr} | Body Diode Reverse Recovery Charge | I _F =20A, dI/dt=100A/μs | 18 | 26 | 34 | nC | | | | |

A. The value of R_{0,0} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on $R_{\theta,JA}$ and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

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B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175° C. Ratings are based on low frequency and duty cycles to keep initial T₁=25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

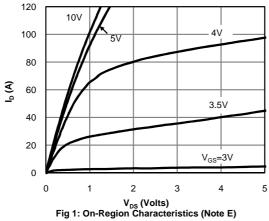
F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =175° C. The SOA curve provides a single pulse rating.

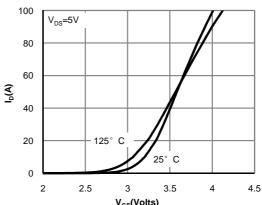
G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

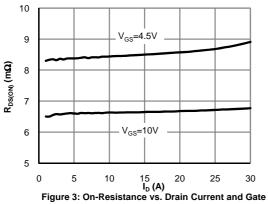


TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





V_{GS}(Volts)
Figure 2: Transfer Characteristics (Note E)



Voltage (Note E)

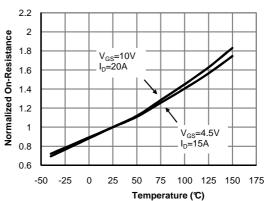
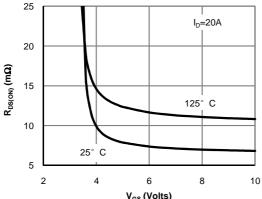
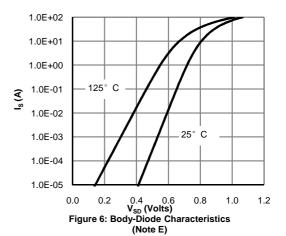


Figure 4: On-Resistance vs. Junction Temperature (Note E)



V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

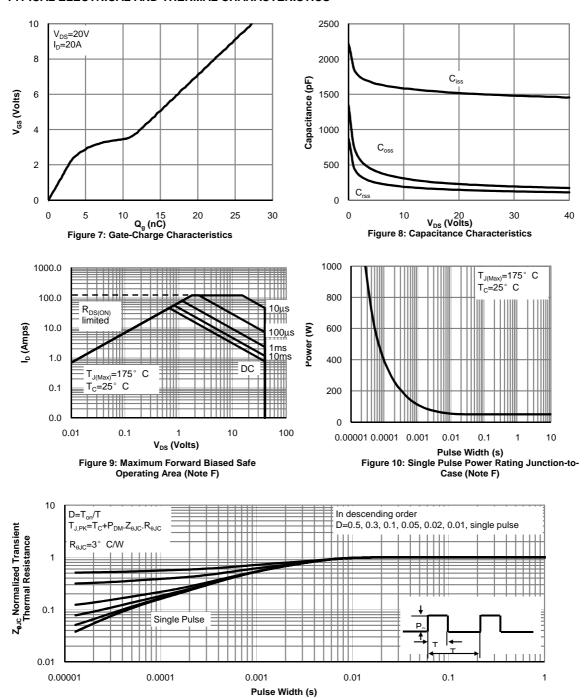


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

1000

100

10

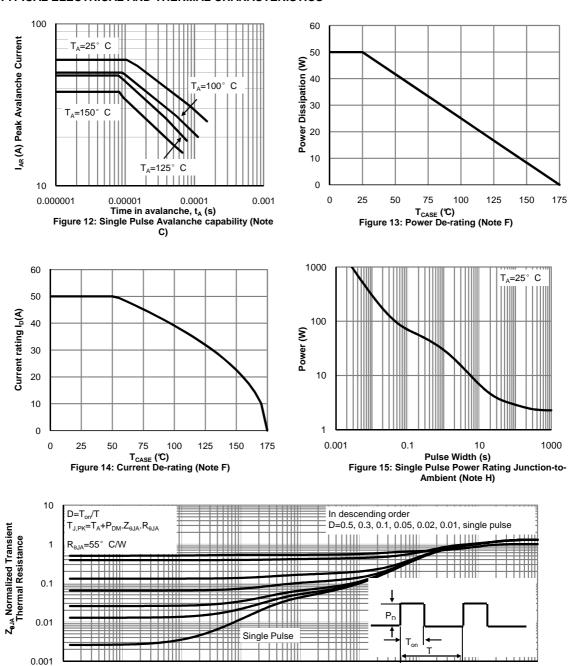


0.00001

0.0001

0.001

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



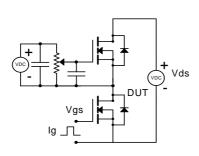
Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

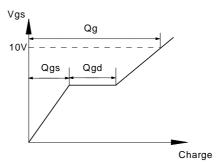
0.1

0.01

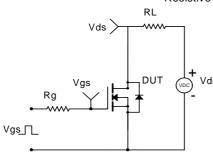


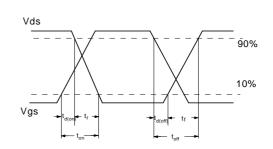
Gate Charge Test Circuit & Waveform



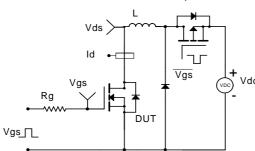


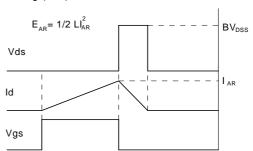
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

